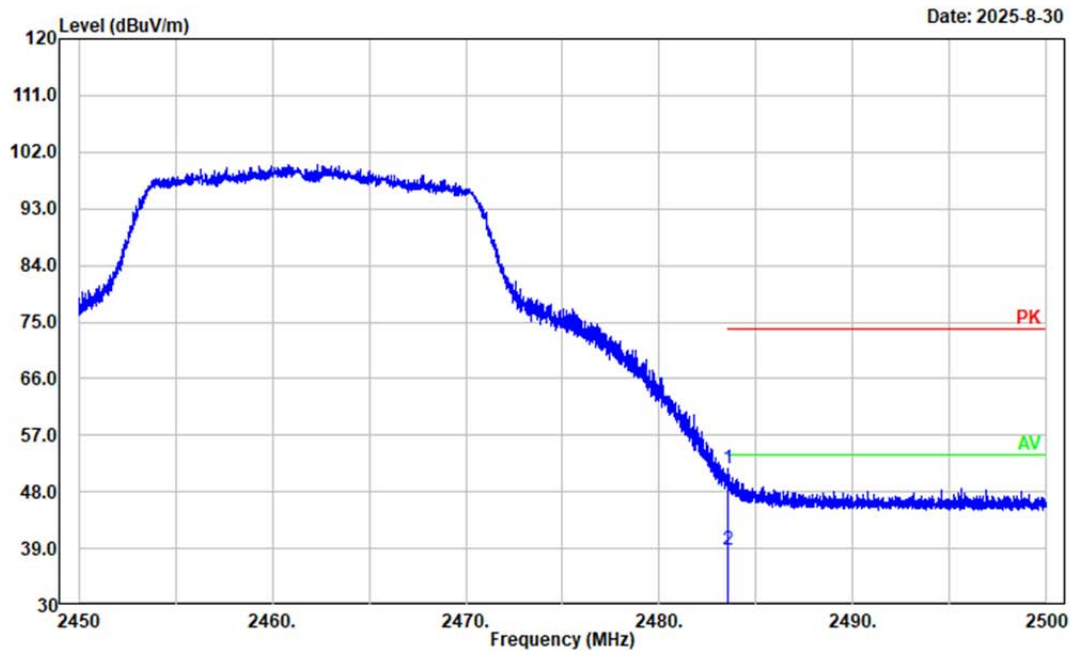
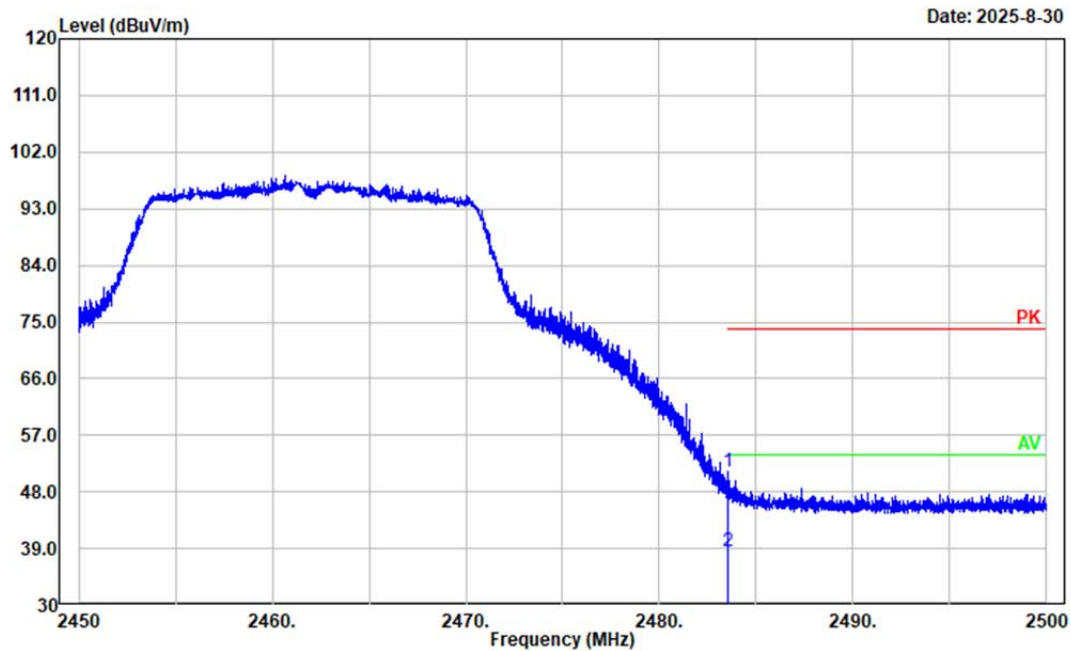


Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Horizontal
Note: n20 High Channel 2462MHz



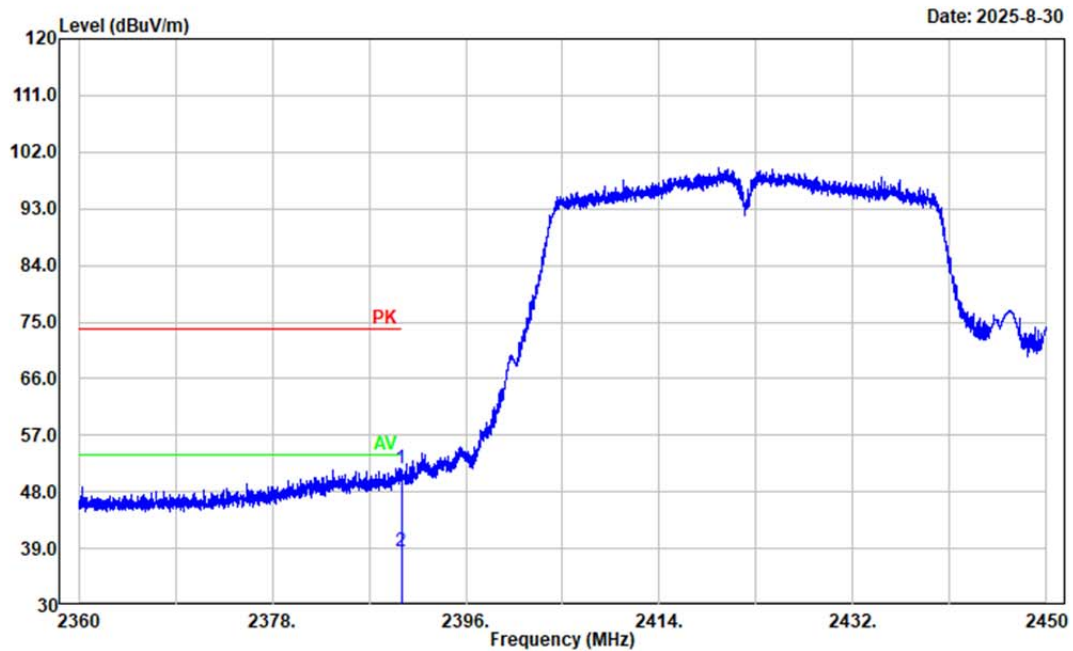
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2483.500	64.51	-12.86	51.65	74.00	22.35	Peak
2	2483.500	51.57	-12.86	38.71	54.00	15.29	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Vertical
Note: n20 High Channel 2462MHz



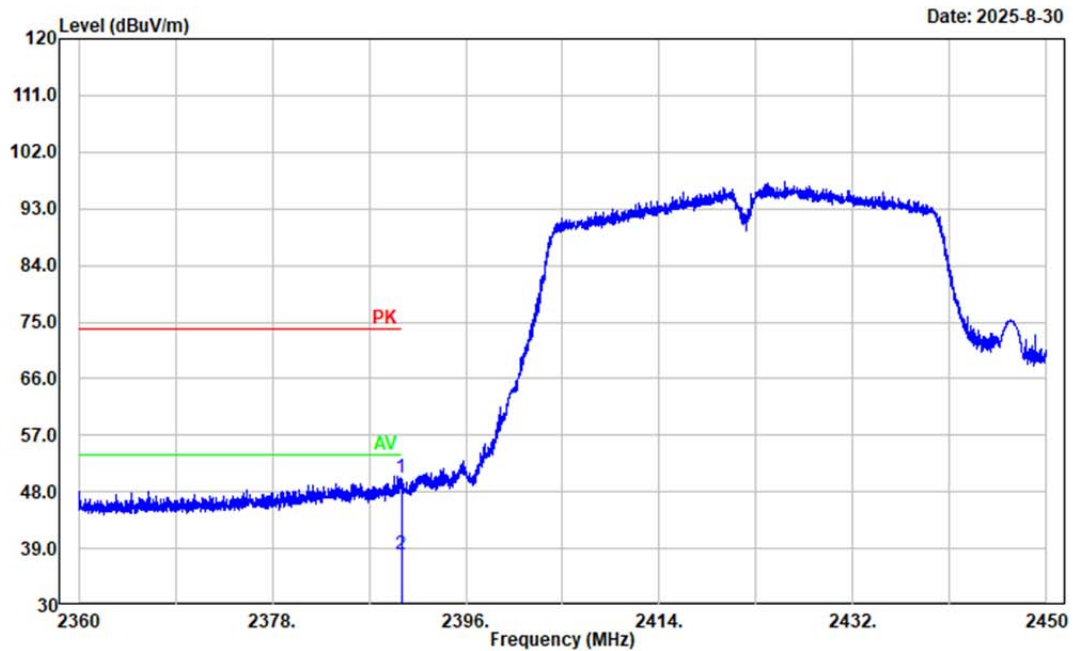
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2483.500	64.09	-12.86	51.23	74.00	22.77	Peak
2	2483.500	51.50	-12.86	38.64	54.00	15.36	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Horizontal
Note: n40 Low Channel 2422MHz



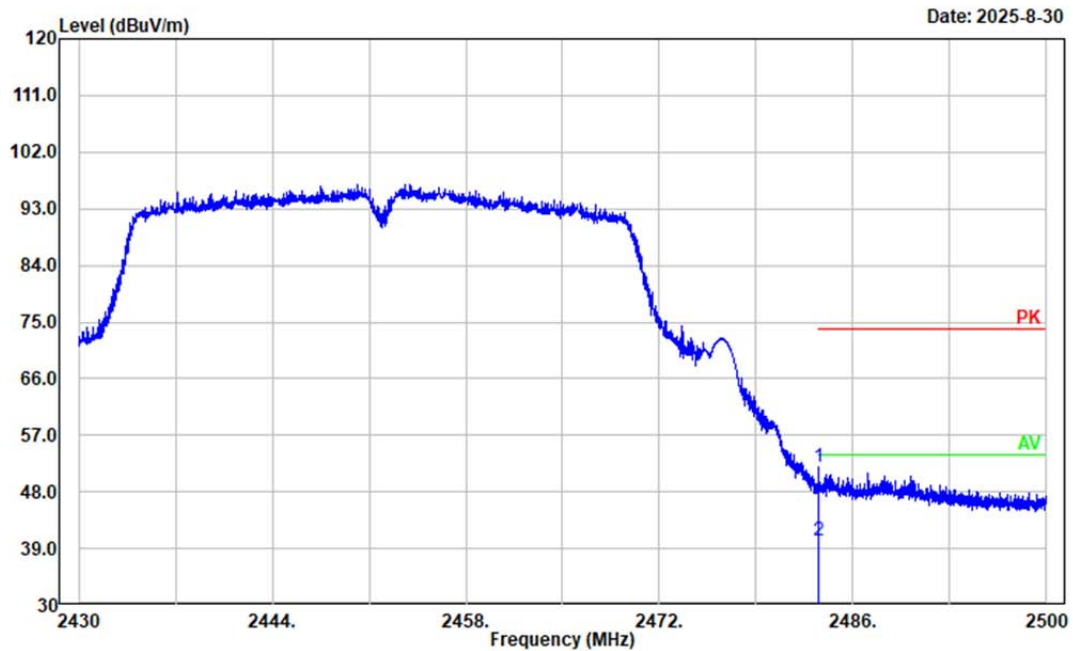
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2390.000	64.78	-13.14	51.64	74.00	22.36	Peak
2	2390.000	51.61	-13.14	38.47	54.00	15.53	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Vertical
Note: n40 Low Channel 2422MHz



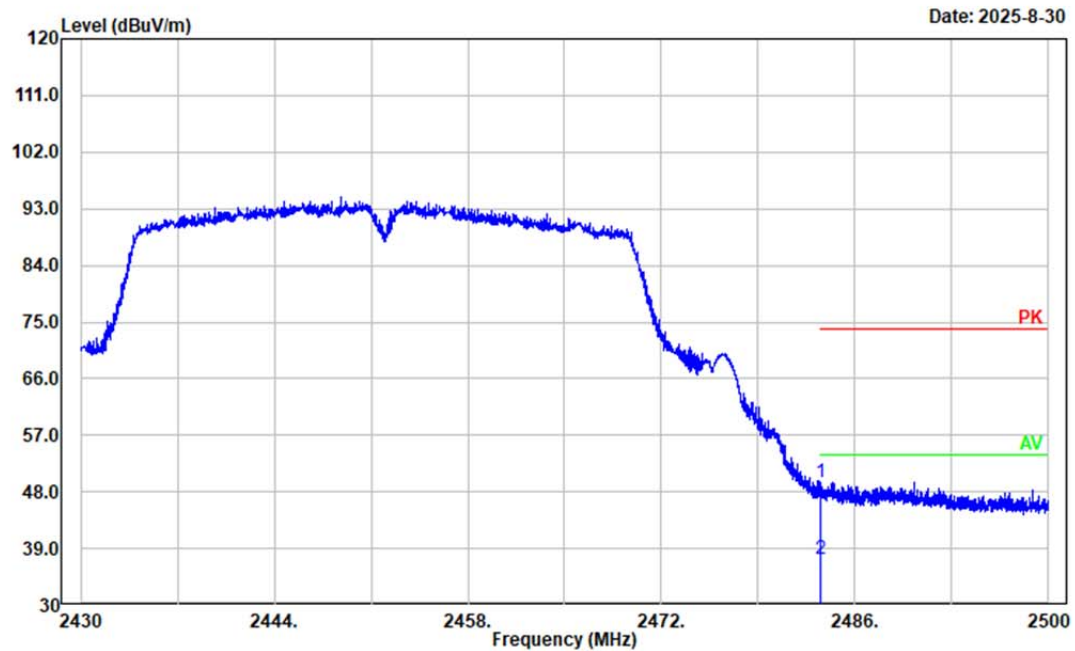
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2390.000	63.37	-13.14	50.23	74.00	23.77	Peak
2	2390.000	51.26	-13.14	38.12	54.00	15.88	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Horizontal
Note: n40 High Channel 2452MHz



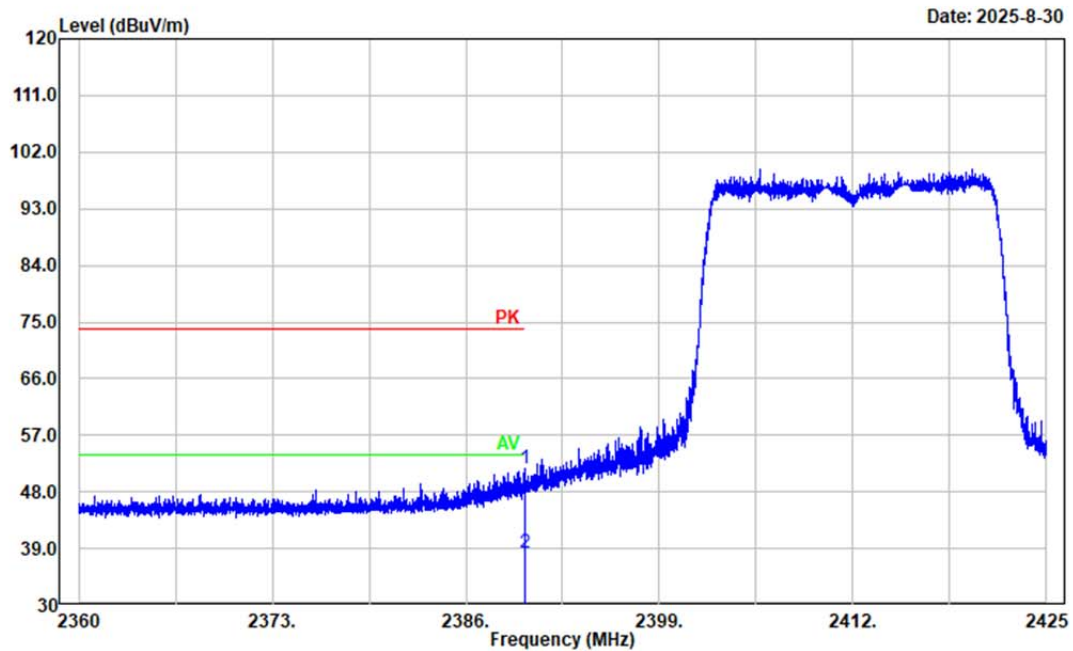
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2483.500	64.89	-12.86	52.03	74.00	21.97	Peak
2	2483.500	53.14	-12.86	40.28	54.00	13.72	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Vertical
Note: n40 High Channel 2452MHz



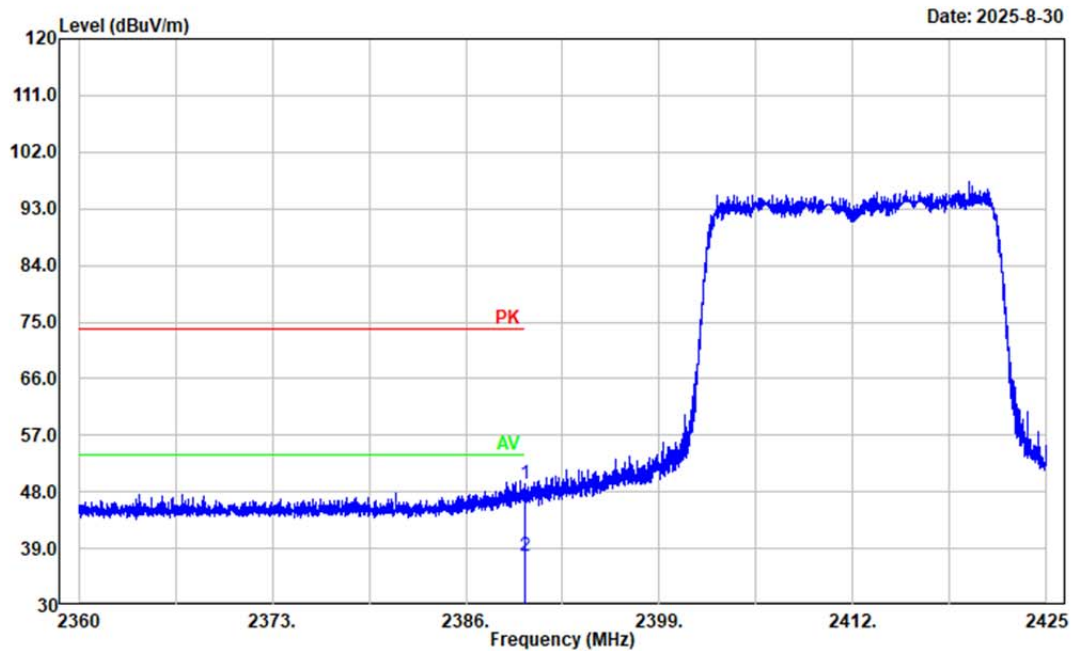
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2483.500	62.48	-12.86	49.62	74.00	24.38	Peak
2	2483.500	50.15	-12.86	37.29	54.00	16.71	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Horizontal
Note: ax20 Low Channel 2412MHz



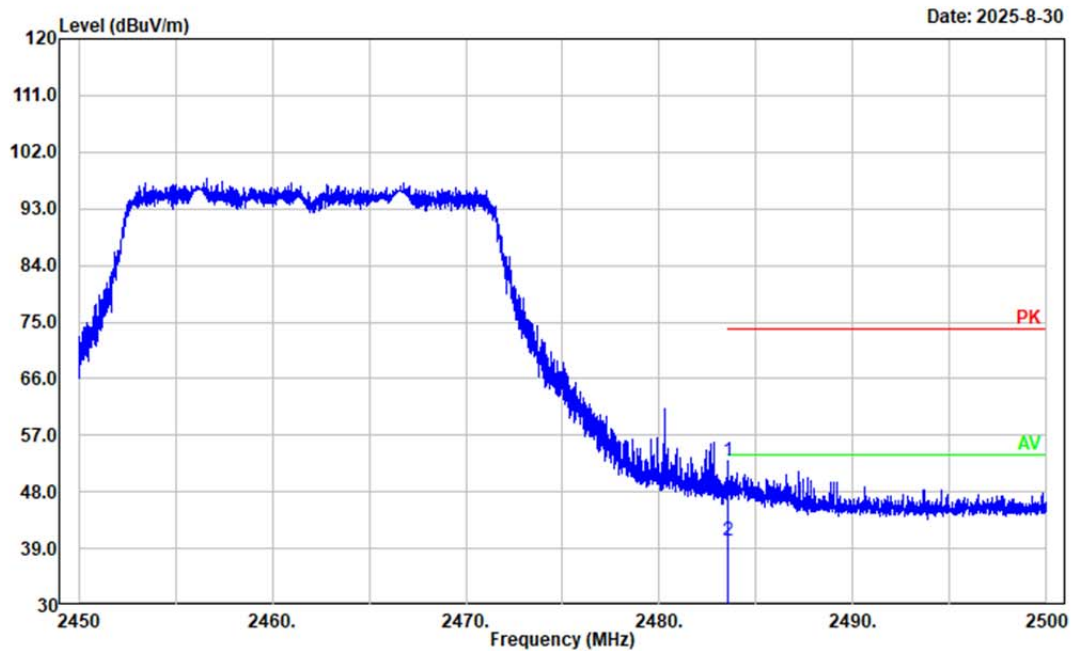
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2390.000	64.88	-13.14	51.74	74.00	22.26	Peak
2	2390.000	51.33	-13.14	38.19	54.00	15.81	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Vertical
Note: ax20 Low Channel 2412MHz



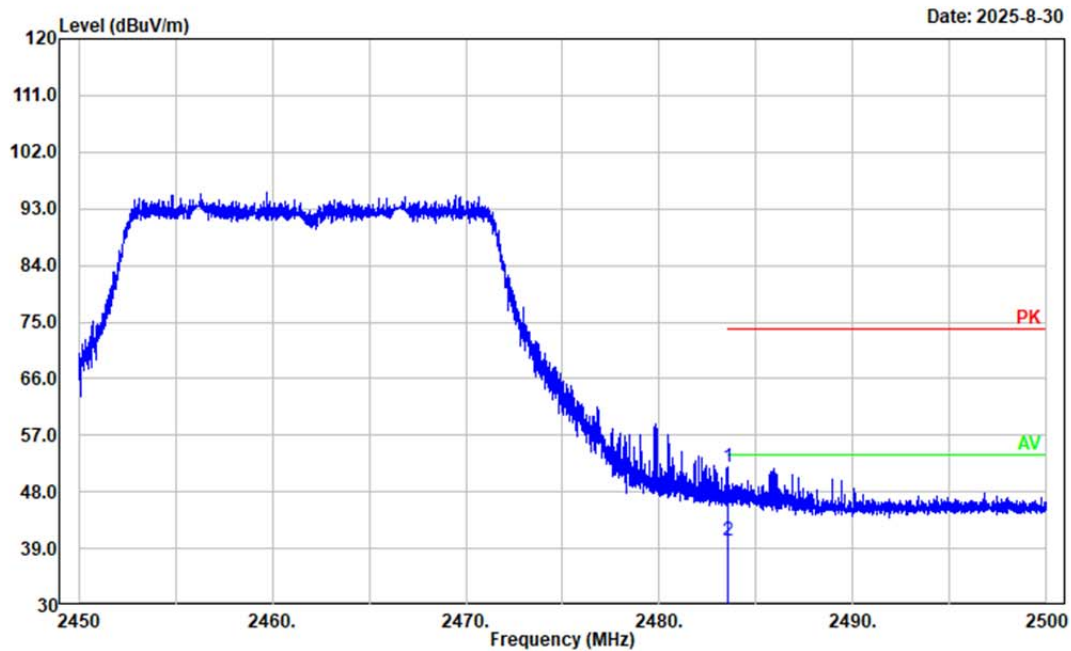
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2390.000	62.46	-13.14	49.32	74.00	24.68	Peak
2	2390.000	50.93	-13.14	37.79	54.00	16.21	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Horizontal
Note: ax20 High Channel 2462MHz



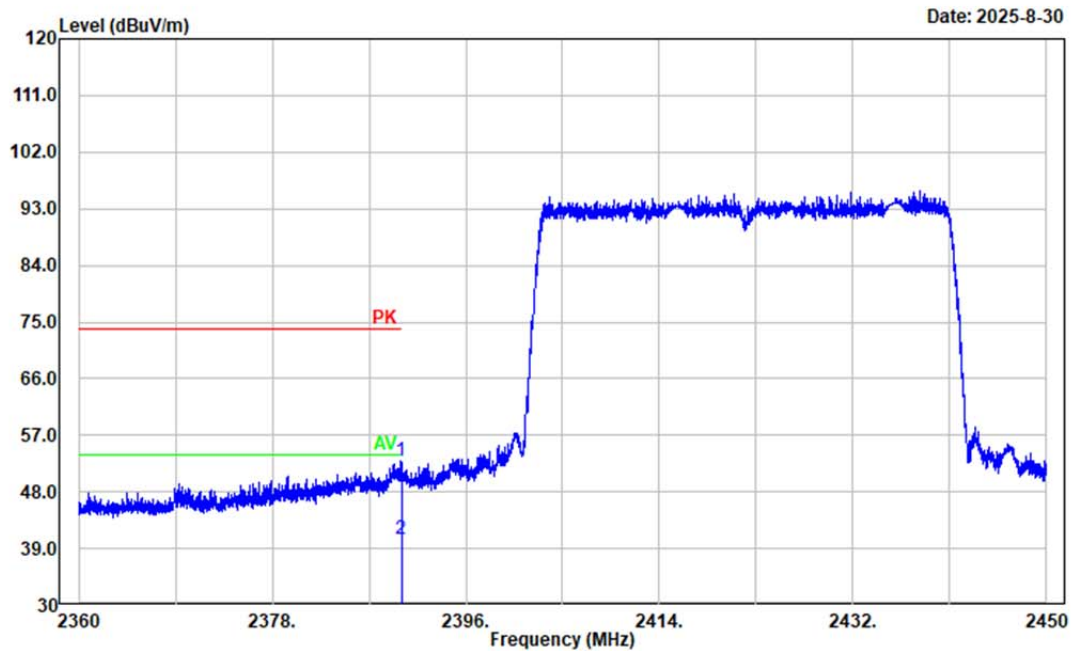
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2483.500	65.75	-12.86	52.89	74.00	21.11	Peak
2	2483.500	53.14	-12.86	40.28	54.00	13.72	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Vertical
Note: ax20 High Channel 2462MHz



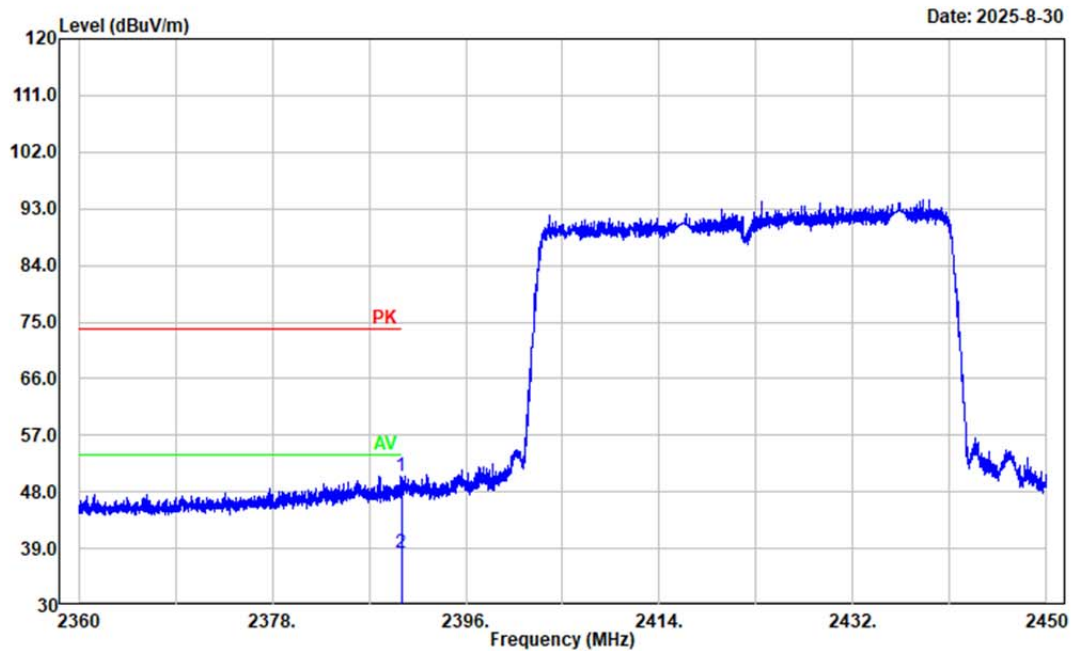
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2483.500	64.90	-12.86	52.04	74.00	21.96	Peak
2	2483.500	53.13	-12.86	40.27	54.00	13.73	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Horizontal
Note: ax40 Low Channel 2422MHz



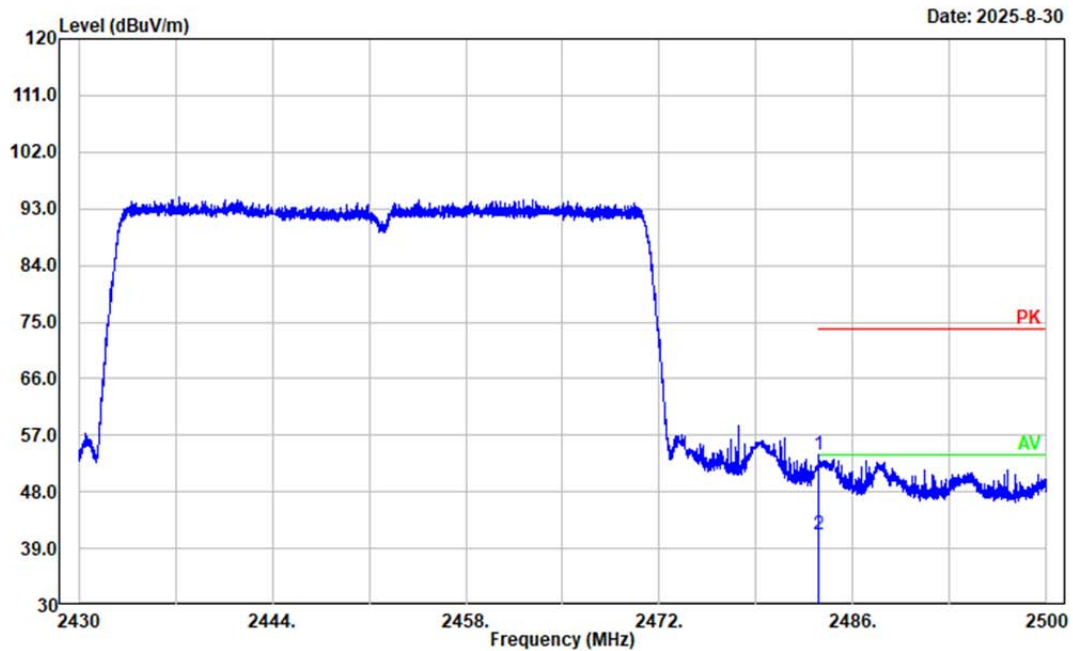
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2390.000	66.13	-13.14	52.99	74.00	21.01	Peak
2	2390.000	53.72	-13.14	40.58	54.00	13.42	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Vertical
Note: ax40 Low Channel 2422MHz



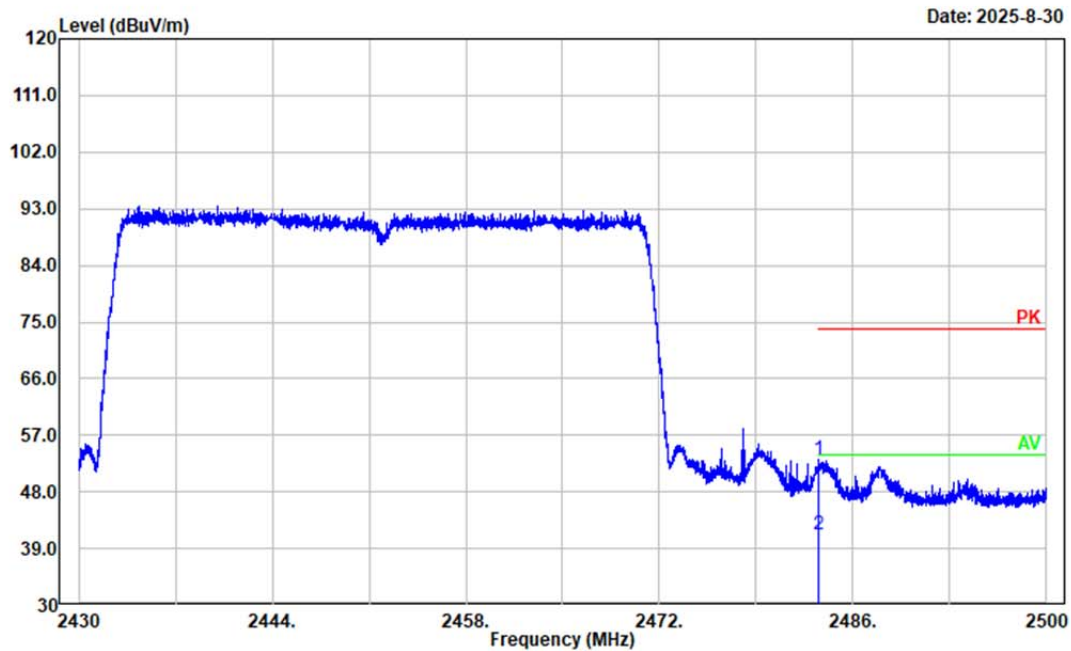
No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2390.000	63.61	-13.14	50.47	74.00	23.53	Peak
2	2390.000	51.32	-13.14	38.18	54.00	15.82	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Horizontal
Note: ax40 High Channel 2452MHz



No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2483.500	66.67	-12.86	53.81	74.00	20.19	Peak
2	2483.500	54.04	-12.86	41.18	54.00	12.82	Average

Project No.: 2503W26909E-RF
Tester: Tao Zhu
Condition: PK trace RBW:1MHz; VBW:3MHz; SWT:0.3sec
Polarization: Vertical
Note: ax40 High Channel 2452MHz



No.	Frequency (MHz)	Reading (dBμV)	Factor (dB/m)	Result (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Remark
1	2483.500	66.12	-12.86	53.26	74.00	20.74	Peak
2	2483.500	54.13	-12.86	41.27	54.00	12.73	Average

4.3 RF Conducted Data

Please refer to Annex "2503W26909E-RF-00C_Appendix A" for detail test data.

5. EUT PHOTOGRAPHS

Please refer to the attachment 2503W26909E-RF-EXP EUT EXTERNAL PHOTOGRAPHS
and 2503W26909E-RF-INP EUT INTERNAL PHOTOGRAPHS

6. TEST SETUPPHOTOGRAPHS

Please refer to the attachment 2503W26909E-RF-00C-TSP TEST SETUP PHOTOGRAPHS.

==== END OF REPORT ====